

Topographic Raman Imaging

100 µm

TrueSurface[™] Microscopy

Chemical Analysis and Profilometry in One Pass

Topographic Raman microscopy image of microstructured silicon with impurities (maximum height variation 8 µm).

https://raman.oxinst.com

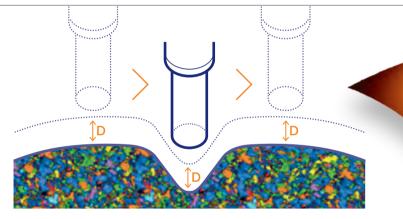
TrueSurface[™] Micros Topographic Raman Imaging

TrueSurface is a patented optical profilometry technology pioneered by WITec. It allows confocal Raman microscopy to be applied to roughly textured and very tilted samples by keeping their surfaces in constant focus. This technique is known as topographic Raman imaging.

Why use TrueSurface? To achieve the highest resolution and signal-to-noise ratio in confocal microscopy, it is essential to keep the sample surface precisely in focus. Measuring rough or inclined samples can thus be challenging. To overcome this obstacle, WITec developed TrueSurface technology. It actively compensates for height variations throughout the entire measurement, resulting in perfectly sharp and detailed images.

Working Principle

A sensor actively monitors and maintains a set distance between the objective and sample surface with submicrometer resolution using closed-loop feedback operation. Thus, Raman imaging can be carried out precisely along or at a set distance from irregular surfaces. Topographic and chemical information are obtained at the same time.

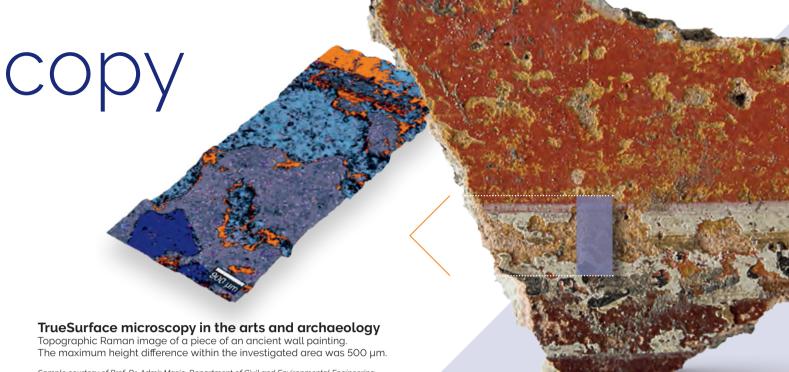


D = Set distance

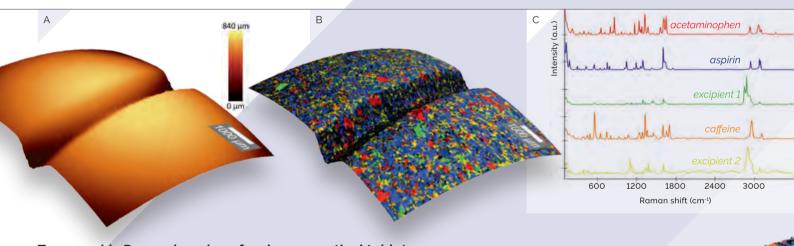
The TrueSurface[™] microscopy option enables the precise tracing of the surface while simultaneously acquiring Raman imaging data, resulting in a topographic Raman image.

Benefits

- One-pass simultaneous optical profilometry and Raman imaging
- Sharp 3D chemical imaging on coarsely textured or inclined samples
- No specialized sample preparation necessary
- Closed-loop feedback to compensate for dimensional variations during long measurements



Sample courtesy of Prof. Dr. Admir Masic, Department of Civil and Environmental Engineering, MIT, Cambridge, MA, USA



Topographic Raman imaging of a pharmaceutical tablet (A) Topography of a painkiller tablet (scan range: 7 x 7 mm²). (B) Topographic Raman microscopy image of the same sample area (overlay of topography and Raman image). (C) Raman spectra of the tablet's chemical components.

Award-Winning Technology







Microscopy Innovation Award Topographic Raman microscopy image of cellulose fibers in paper.



WITec Microscopes

alpha300 S: Scanning Near-field Optical Microscope alpha300 A: Atomic Force Microscope

alpha300 apyron ": Automated Confocal Raman Microscope

alpha300 R: Microscope

> alpha300 access: Confocal Micro-Raman System

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alpha300 Ri:

Inverted Confocal

Raman Microscope

RISE[®]: Raman Imaging and Scanning Electron Microscope

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Explore the TrueSurface product page



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